Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/783,770	YUAN ET AL.		
Examiner	Art Unit		
Ramsey Zacharia	1773		

	SEARCHED				
Class	Subclass	Date	Examiner		
428	66.4 313.3	1/4/2006	REZ		
	213 323				
	328 330				
	327 329				
1	421 313.5		\		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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eDAN inventor search	1/4/:	2006	REZ
EAST text search	1/4/2	2006	REZ